

An Integral Equation Scheme for Plasma based Thin Sheets

Abstract—An integral equation formulation for a thin dielectric sheet is presented using the surface equivalence theorem. The advantageous properties of plasma waves, chief among them surface wave propagation are briefly discussed. Numerical results are presented to illustrate the scattering properties of the sheet with different material properties.

I. INTRODUCTION

The emergence of high-precision nanoscale fabrication techniques has recently led to an increased interest in two-dimensional (2D) materials, especially in the terahertz frequency regime and superconductive devices. One particularly intriguing example is the two-dimensional electron gas (2DEG) existing in the multilayer stack of semiconductor structures like high-electron mobility transistors (HEMTs), with remarkable electrical properties such as very high values of free-electron densities as compared to bulk semiconductors. These free electrons form an extremely thin and conductive channel in the stack. We observe the scattering properties of the 2DEG by modeling it as an infinitesimally thin sheet of plasma. An interaction between an external electromagnetic radiation and plasma results in 2D plasmons (surface waves). In this paper, we formulate the scattering response of the plasma sheet surrounded by free-space using the surface equivalence theorem.

II. THEORY

A. Surface Plasmons

The electrical properties of any material can be characterized by a frequency-dependent permittivity:

$$\varepsilon(\omega) = \varepsilon_r - j \frac{\sigma(\omega)}{\omega} \quad (1)$$

where ε_r is the permittivity of the material at dc frequency and σ is the conductivity given by a Drude-type model [1]:

$$\sigma(\omega) = \frac{Ne^2\tau}{m^*} \frac{1}{1 + j\omega\tau} \quad (2)$$

The parameters e and m^* are the charge and effective mass of an electron respectively, N is free-charge density, and τ is the scattering time of free charges in the 2DEG determined by the electron mobility, μ_e :

$$\tau = \frac{m^*\mu_e}{e}. \quad (3)$$

The dispersion relation for 2D plasma waves can be written in terms of the plasma frequency ω_p and wave-number k :

$$\omega_p = \sqrt{\frac{2\pi e^2 N}{m^*}} k. \quad (4)$$

B. Surface Integral Equation

Consider a flat plasma sheet of length L and thickness t excited by a TM_z polarized plane wave as illustrated in Fig. 1. The plasma is assumed nonmagnetic and the dielectric constant is determined from (1)-(4). By applying the surface equivalence theorem [2, p. 328-333], the plasma sheet is replaced by an equivalent set of surface electric and magnetic currents. For the case of 2DEG plasma, the thickness is treated as the limiting case where $t \rightarrow 0$. The resulting electric field integral equation (EFIE) in a homogeneous free-space is written as:

$$E_i = \frac{\omega\mu}{4} \int_0^L J_z(x') \left[H_0^{(2)}(k_1 r) + H_0^{(2)}(k_2 r) \right] dx' \quad (5)$$

where μ is the free-space permeability, J_z is the yet-unknown surface electric current, $H_n^{(2)}(\cdot)$ is the n -th order Hankel function of the second kind and k_i with $i = 1, 2$ are the corresponding wave-numbers of the free-space and plasma respectively, and $r = |x - x'|$. The corresponding magnetic field

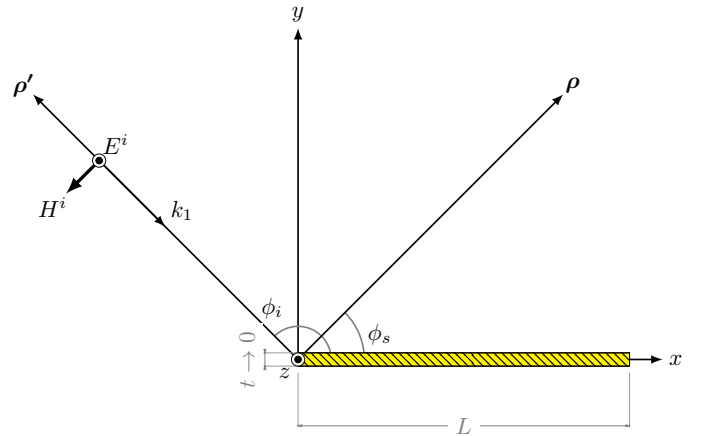


Fig. 1. Thin Plasma sheet under TM_z polarized plane wave

expressed in terms of the magnetic current M_x is expressed as:

$$H_i = \frac{\omega\mu}{8} \int_0^L M_x(x') \left[\varepsilon_1 H_0^{(2)}(k_1 r) + \varepsilon_1 H_2^{(2)}(k_2 r) + \varepsilon_2 H_0^{(2)}(k_2 r) + \varepsilon_2 H_2^{(2)}(k_2 r) \right] dx' \quad (6)$$

The expressions for TE_z polarization are duals of (5) and (6).

III. NUMERICAL RESULTS

A method of moments (MoM) solution using pulse basis functions with point matching method is implemented to compute the currents in (5) and (6) respectively. The far-field is calculated using the Total Field Scattered Field (TFSF) technique determined by:

$$\sigma_\phi \simeq \int_0^L [J_z(x')\eta_1 + M_x(x')\sin(\phi_i)] e^{jk_1 x' \cos(\phi_i)} dx' \quad (7)$$

where η_1 is the free-space intrinsic impedance and ϕ_i is the angle of incidence. We explore the scattering properties of Gallium Arsenide (GaAs/AlGaAs) and Strontium Titanate (LaAlO₃/SrTiO₃) based 2DEG plasma sheets where pertinent material data has been taken from measurements in [1] and [3] respectively, and the results are compared with a PEC plate of same length. Fig. 3 shows the backscatter cross-sections from Gallium Arsenide and Strontium Titanate based sheets are reduced, but not appreciably. Although the result is expected to be lower than the perfect conductor, a relatively small difference illustrates the potentials of such materials in applications such as plasmonic antennas and waveguides. In particular, a 2DEG made from Strontium Titanate with its higher dielectric constant appears to be a better choice.

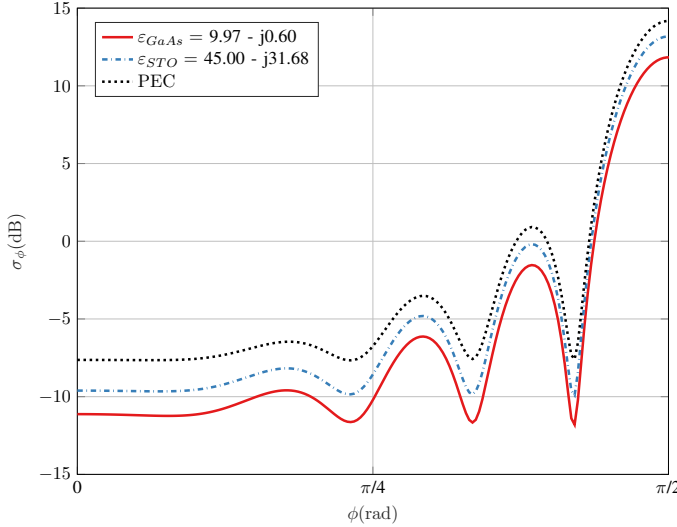


Fig. 2. Backscattered fields from different sheets of length 2λ under TM_z incidence

In order to verify the integral equation proposed, we next consider a sheet of length 2λ and dielectric constant of 4 excited by a TE_z polarized plane wave. Fig. 3 shows the backscattered field computed from (7) compared with a resistive-sheet model [4] using Impedance boundary conditions. The results agree well until incident angle of $\pi/4$ below which the diffraction effects from the edges, due to finite thickness of the resistive sheet becomes significant.

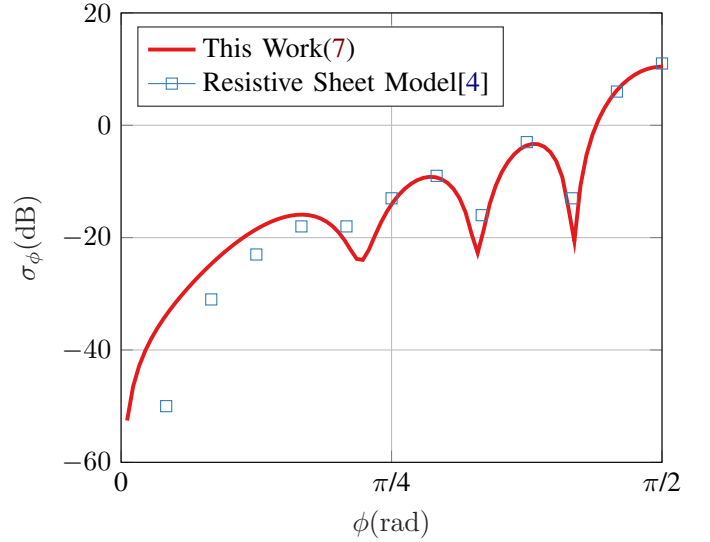


Fig. 3. Comparison of Backscattered fields from a sheet of length 2λ with $\epsilon_2 = 4$ under TE_z polarization with [4]

IV. CONCLUSION

We present a new class of surface integral equations for infinitesimally thin dielectric sheets based on surface equivalence theorem. The prospects of 2DEG based antennas and plasmonic devices are investigated by exploring the scattering properties of the structures. Results are shown for different polarizations and compared with the state-of-the art literature. Additionally, material characterization using measurable physical quantities is outlined.

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